

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/775,768	MIKOS ET AL.	
				Examiner	Art Unit	
				David M. Naff	1651	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
				09 / 469-760	6/23/06	~
					1	1
				<u>West</u> see patent		
					3/19/07	~
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			